

10/533793

PATENT

JC17 Rec'd PCT/PTO 04 MAY 2005
105684101

IN THE U.S. PATENT AND TRADEMARK OFFICE

In re application of

Wim TEULINGS et al.

Conf.

Application No. NEW NATIONAL PHASE

Group

Filed May 4, 2005

Examiner

DEVICE FOR MEASURING ELECTRIC CURRENT INTENSITY

**INFORMATION DISCLOSURE STATEMENT
(SUBMISSION CONCURRENT WITH THE
FILING OF A NEW PATENT APPLICATION)**

Assistant Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

May 4, 2005

Sir:

Pursuant to 37 C.F.R. §§ 1.97 and 1.98, and in fulfillment of the duty of disclosure under 37 C.F.R. § 1.56, applicant(s) hereby submit(s) an Information Disclosure Statement for consideration by the Examiner.

I. LIST OF PATENTS, PUBLICATIONS OR OTHER INFORMATION

The patents, publications, or other information submitted for consideration by the Office are listed on PTO-1449, attached hereto.

II. COPIES

- Copies of the U.S. patents or publications are not submitted since the USPTO has waived their submission for applications filed after June 30, 2003.
- Submitted herewith is a legible copy of (i) each foreign patent; (ii) each publication or that portion which caused it to be listed; and (iii) all other information or that portion which caused it to be listed.
- This application is a National Phase of a PCT application. Some or all of the documents listed on the PTO-1449 are not enclosed because they were cited in the International Search Report and copies should have been forwarded from the International Search Authority pursuant to the trilateral agreement between the USPTO, EPO and JPO, or they are U.S. patents or U.S. published applications. If copies are needed, please contact the undersigned.

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III. CONCISE EXPLANATION OF THE RELEVANCE
(check at least one box)

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a. **DOCUMENTS IN THE ENGLISH LANGUAGE**

The attached non U.S. patents, non U.S. patent application publications, foreign publications, or other information in the English language do not require a statement of relevancy.

b. **DOCUMENTS NOT IN THE ENGLISH LANGUAGE**

A concise explanation of the relevance of all patents, publications, or other information listed that is not in the English language is as follows:

c. **FOREIGN SEARCH REPORT OR ACTION**

An English language version of the search report or action that indicates the degree of relevance found by the foreign office is attached, thereby satisfying the requirement for a concise explanation. See MPEP 609(A)(3).

d. **OTHER**

The following additional information is provided for the Examiner's consideration.

FEES

This Information Disclosure Statement is being filed concurrently with the filing of a new patent application; therefore, no fee is required.

If The Examiner has any questions concerning this IDS, he/she is requested to contact the undersigned.

Respectfully submitted,

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Enclosures: Form PTO-1449(s)
 Documents
 Foreign Search Report
 Other: _____

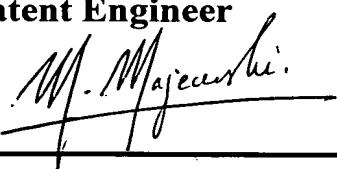
No.	Document	Comments
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X	From Search Report	
	DE 41 42 342 A (Sew Eurodrive GmbH & Co)	No equivalent English document
	DE 196 42 472 A (Abb Research Ltd)	No equivalent English document
	DE 26 32 377 A (Friedl Richard)	No equivalent English document

	Quoted in the preamble of the description	
	DE 196 42 472 A (Abb Research Ltd)	No equivalent English document
	DE 197 05 767 (Vacuumschmelze GmbH)	No equivalent English document
	DE 197 05 768 (Vacuumschmelze GmbH)	See US 6,177,791 B1
	DE 199 19 602 (Vacuumschmelze GmbH ; Semikron Electronik GmbH)	See US 6,713,999 B1

	Other documents of the Prior Art	

	Related US applications	

Signature of the Patent Engineer	Date
Marc MAJEWSKI 	April 21th, 2005

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.

* English language abstract provided for the Examiner's convenience

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